Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/081,673	RAMANATHAN ET AL.
Examiner	Art Unit
Jungwon Chang	2154

SEARCHED				
Class	Subclass	Date	Examiner	
709	217	11/17/2005	JWC	
709	219	11/17/2005	JWC	
709	203	11/17/2005	JWC	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	217	11/17/2005	JMC	
709	219	11/17/2005	JWC	
709	203	11/17/2005	JWC	

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	DATE	EXMR
East text NPL: Google ACM IEEE search report attached	11/17/2005	JWC